# FAIRCHILD

SEMICONDUCTOR

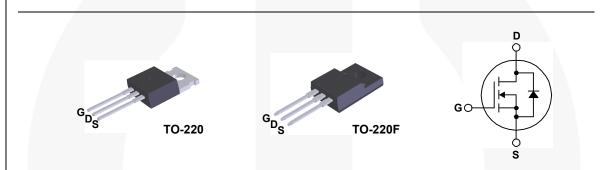
# FQP5N60C / FQPF5N60C **N-Channel QFET® MOSFET** 600 V, 4.5 A, 2.5 Ω

# Description

This N-Channel enhancement mode power MOSFET is • 4.5 A, 600 V, R<sub>DS(on)</sub> = 2.5 Ω (Max.) @ V<sub>GS</sub> = 10 V, produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state • Low Gate Charge (Typ. 15 nC) resistance, and to provide superior switching performance • Low Crss (Typ. 6.5 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power • 100% Avalanche Tested factor correction (PFC), and electronic lamp ballasts.

#### Features

- I<sub>D</sub> = 2.25 A



## Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted.

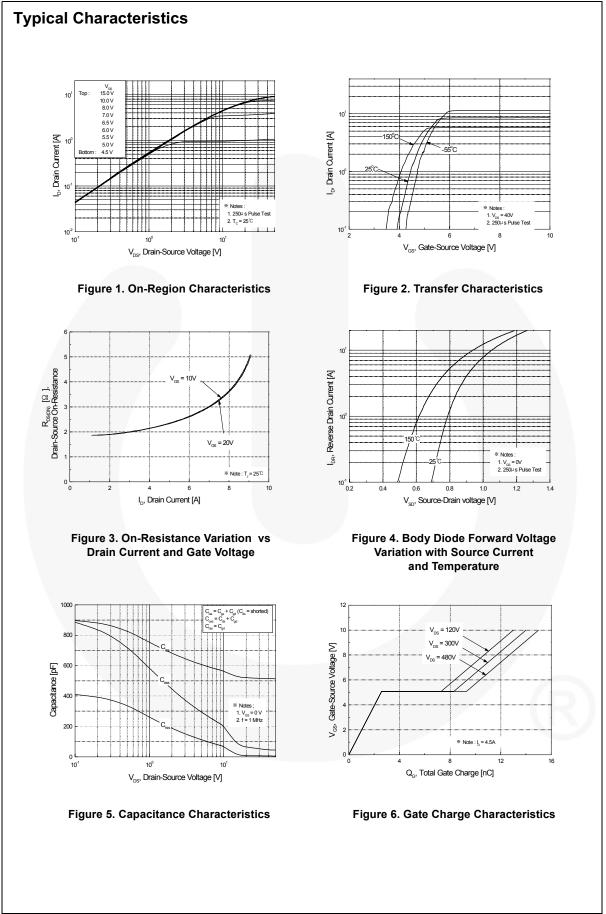
Symbol	Parameter	FQP5N60C	Unit V		
V <sub>DSS</sub>	Drain-Source Voltage	6			
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		4.5	4.5 *	А
	- Continuous (T <sub>C</sub> = 100°C)	_	2.6	2.6 *	А
I <sub>DM</sub>	Drain Current - Pulsed (N	ote 1)	18	18 *	А
V <sub>GSS</sub>	Gate-Source Voltage	±	V		
E <sub>AS</sub>	Single Pulsed Avalanche Energy (N	ote 2)	210		mJ
I <sub>AR</sub>	Avalanche Current (N	ote 1)	4.5		Α
E <sub>AR</sub>	Repetitive Avalanche Energy (N	ote 1)	10		mJ
dv/dt	Peak Diode Recovery dv/dt		4.5		V/ns
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C)		100	33	W
	- Derate above 25°C	0.8	0.26	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150		°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		3	°C	

## **Thermal Characteristics**

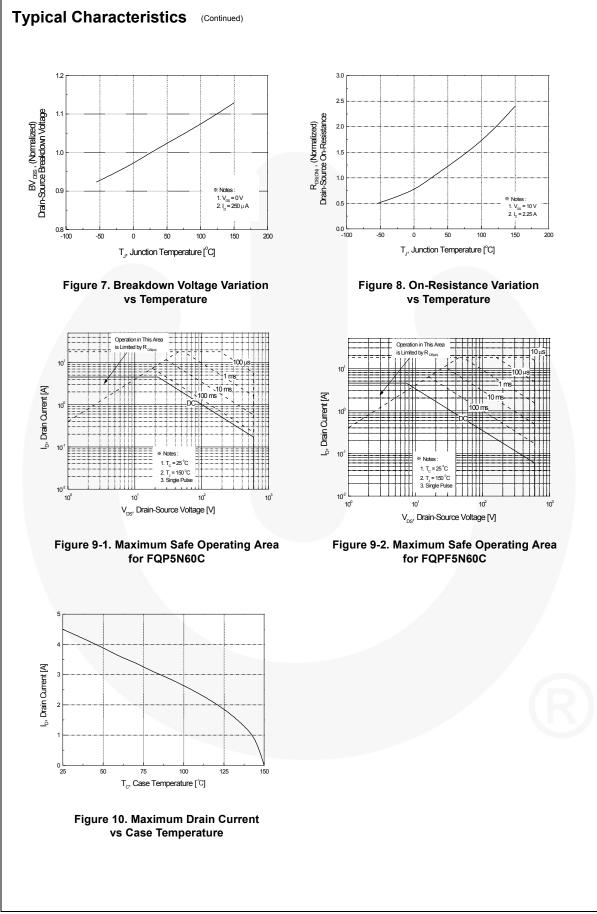
Symbol	Parameter	FQP9N90C	FQPF9N90CT	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	1.25	3.79	°C/W	
R <sub>0CS</sub>	Thermal Resistance, Case-to-Sink Typ, Max.	0.5		°C/W	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W	

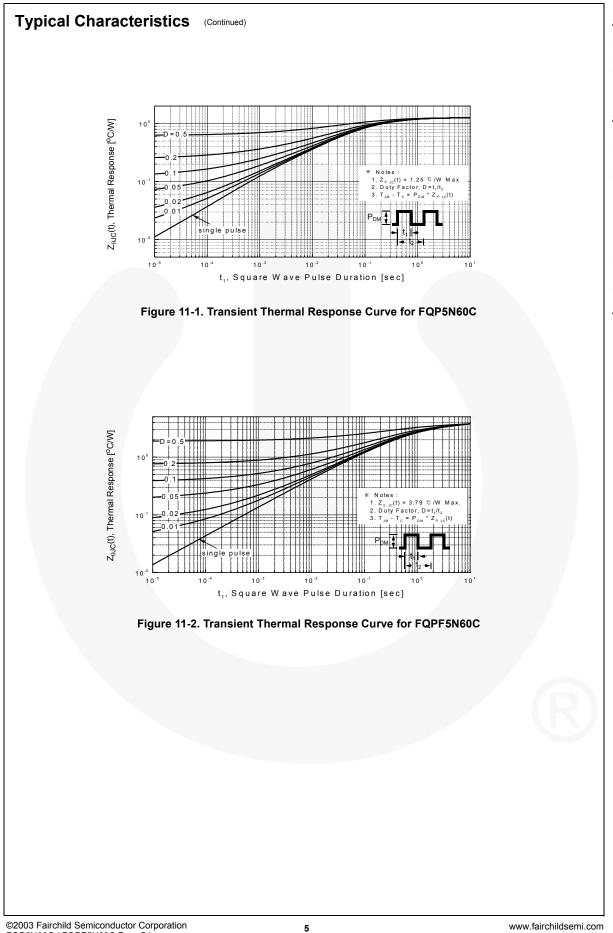
December 2013

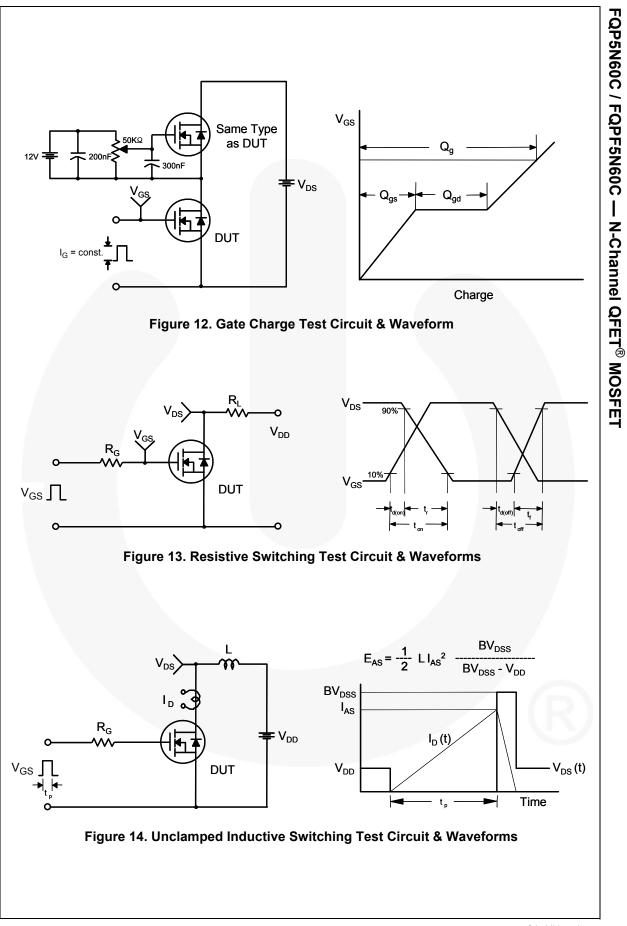
FQP5N60C FQP5N60C TO		Top Mark	Pack	kage Packing Method Re		Reel S	Size	Tape Width		Quantity		
		FQP5N60C		220	Tube		N/A		N/A		50 units	
		220F Tube N/				Ą	N/A		50 units			
lectric	cal Cha	racteristics	T <sub>C</sub> = 25°C	cunless oth	nerwise noted.							
Symbol		Parameter			Test Con	ditions		Min.	Тур.	Max.	Unit	
Off Cha	aracterist	ics										
BV <sub>DSS</sub>		rce Breakdown Volta	ade	$V_{CS} =$	0 V, I <sub>D</sub> = 25	50 uA		600			V	
ΔBV <sub>DSS</sub>	Breakdown Voltage Temperature											
/ $\Delta T_{\rm J}$		Coefficient		$I_D = 250 \ \mu\text{A}$ , Referenced to 25°C				0.6		V/°C		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current			V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V					1	μA		
				$V_{DS} = 480 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$						10	μA	
GSSF		y Leakage Current, I		$V_{GS} = 30 V, V_{DS} = 0 V$ $V_{GS} = -30 V, V_{DS} = 0 V$				100	nA			
GSSR	Gate-Bod	y Leakage Current, F	Reverse	v <sub>GS</sub> =	-30 V, V <sub>DS</sub>	= 0 V				-100	nA	
On Cha	racterist	ics										
V <sub>GS(th)</sub>		shold Voltage		V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = 2	50 µA		2.0		4.0	V	
R <sub>DS(on)</sub>	Static Dra On-Resist			-	10 V, I <sub>D</sub> = 2				2.0	2.5	Ω	
9 <sub>FS</sub>	Forward T	ransconductance	_	V <sub>DS</sub> =	40 V, I <sub>D</sub> = 2	2.25 A			4.7		S	
									I			
-	1	cteristics	_	1								
C <sub>iss</sub>	Input Cap		_	_	25 V, V <sub>GS</sub> =	= 0 V,			515	670	pF	
C <sub>oss</sub>		pacitance	_	f = 1.0	MHz				55	72	pF	
C <sub>rss</sub>	Reverse	ransfer Capacitance	;						6.5	8.5	pF	
Switchi	ing Chara	acteristics										
t <sub>d(on)</sub>		Delay Time	_	Vpp =	300 V, I <sub>D</sub> =	4.5			10	30	ns	
t <sub>r</sub>	Turn-On F	Rise Time			= 25 Ω	ч.0			42	90	ns	
t <sub>d(off)</sub>	Turn-Off E	elay Time		,,G					38	85	ns	
t <sub>f</sub>	Turn-Off F	all Time					(Note 4)		46	100	ns	
Qg	Total Gate	Charge		V <sub>DS</sub> =	480 V, I <sub>D</sub> =	4.5 A,			15	19	nC	
Q <sub>gs</sub>	Gate-Sou	rce Charge		V <sub>GS</sub> =					2.5		nC	
Q <sub>gd</sub>	Gate-Drai	n Charge					(Note 4)	-	6.6		nC	
Ť.									I		/	
Drain-S	ource Di	ode Characteri	stics ar	nd Max	cimum R	atings						
I <sub>S</sub>	Maximum	Continuous Drain-S	ource Dic	de Forw	ard Curren	t				4.5	Α	
I <sub>SM</sub>	Maximum	Pulsed Drain-Sourc	e Diode F	orward	Current					18	Α	
V <sub>SD</sub>	Drain-Sou	rce Diode Forward \	/oltage	V <sub>GS</sub> =	0 V, I <sub>S</sub> = 4.	5 A				1.4	V	
t <sub>rr</sub>	Reverse F	Recovery Time			0 V, I <sub>S</sub> = 4.				300		ns	
Q <sub>rr</sub>	Reverse F	Recovery Charge		dl <sub>F</sub> / dt	: = 100 A/μs	6		-	2.2		μC	

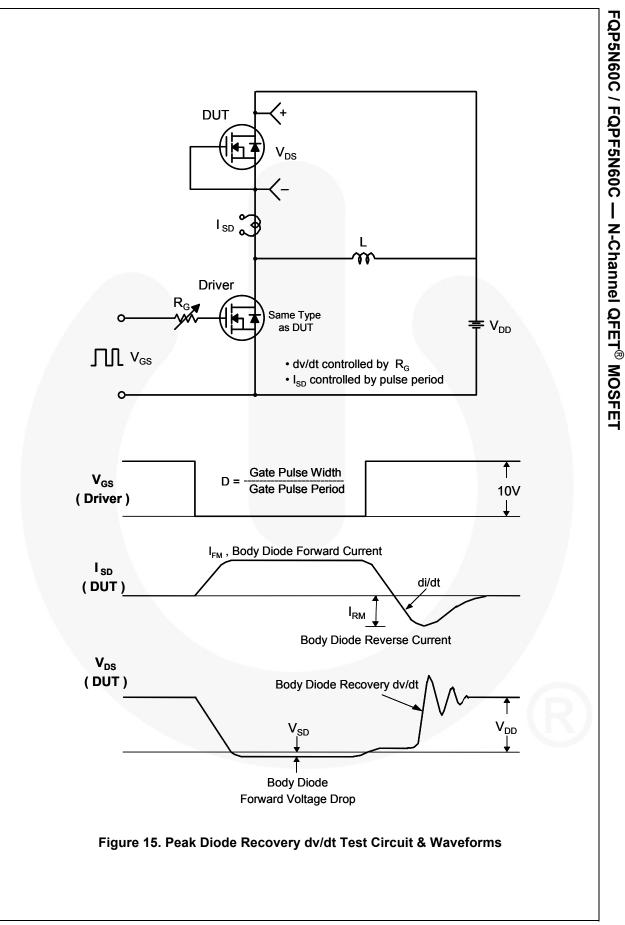


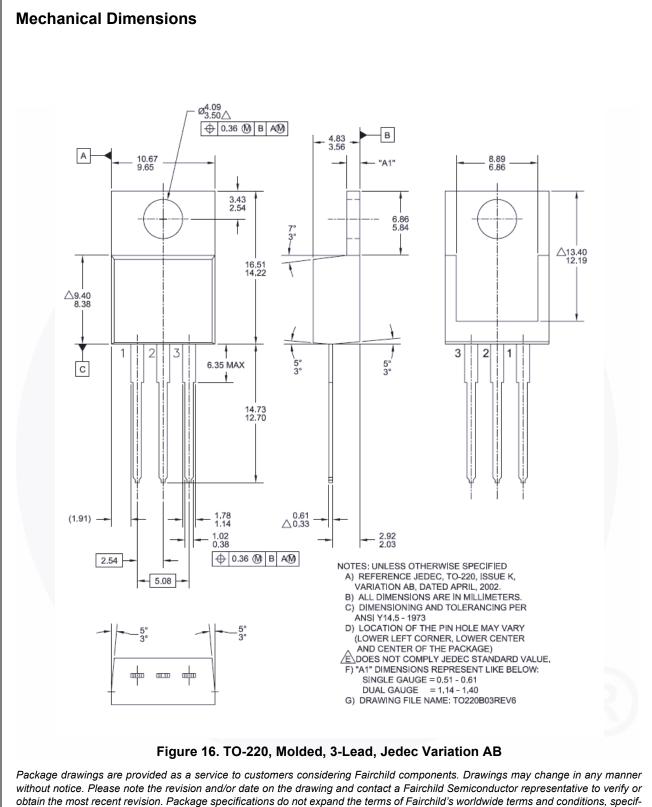
FQP5N60C / FQPF5N60C — N-Channel QFET<sup>®</sup> MOSFET











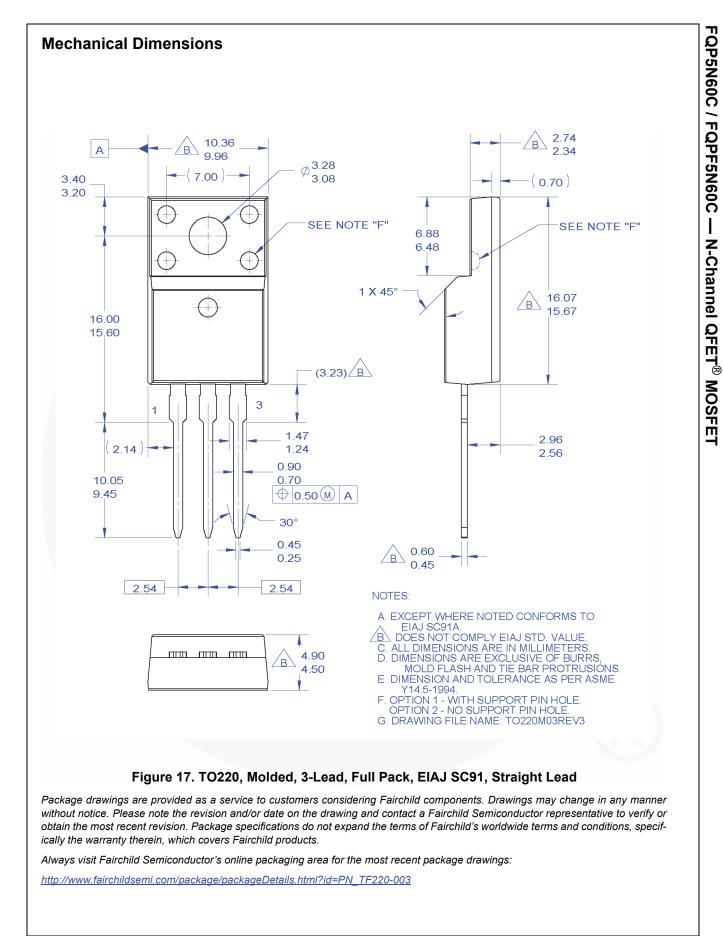
N-Channel QFET<sup>®</sup> MOSFET

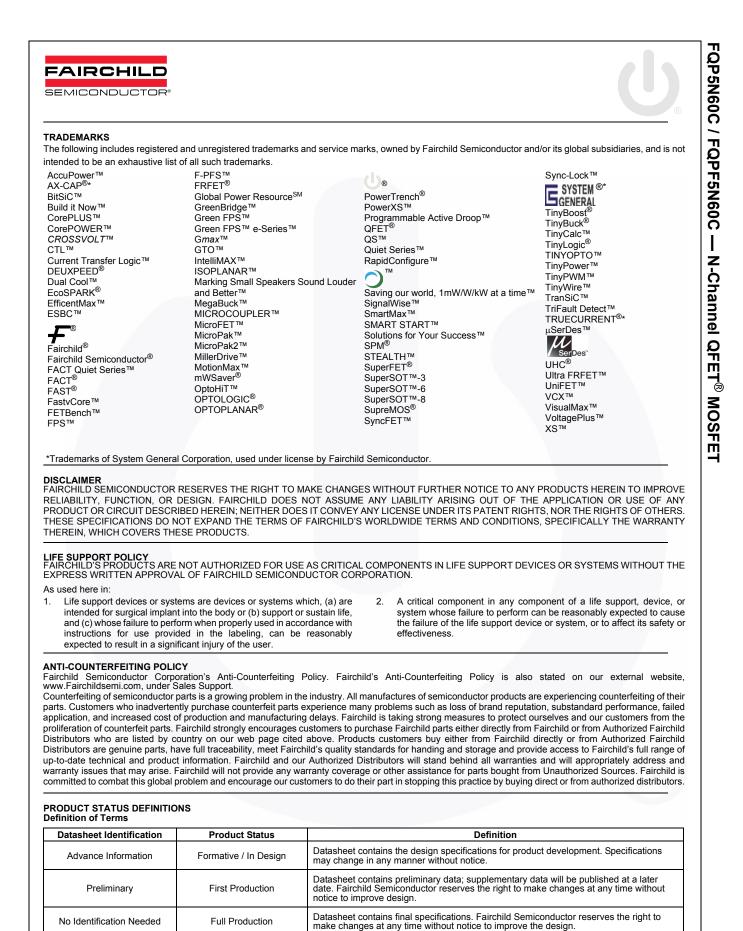
FQP5N60C / FQPF5N60C ---

Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings:

http://www.fairchildsemi.com/package/packageDetails.html?id=PN\_TT220-003

ically the warranty therein, which covers Fairchild products.





Not In Production

Obsolete

Datasheet contains specifications on a product that is discontinued by Fairchild

Semiconductor. The datasheet is for reference information only.

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